Unit: mm

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π–MOSV)

2SK2916

DC-DC Converter, Relay Drive and Motor Drive Applications

• Low drain–source ON resistance : RDS (ON) = 0.35Ω (typ.)

 $\bullet \quad \text{High forward transfer admittance} \quad \ \vdots \ | \, Y_{fs} \, | \, = 11 \, \, S \, (typ.)$

• Low leakage current $: IDSS = 100 \mu A (max) (VDS = 500 V)$

• Enhancement–mode $: V_{th} = 2.0 \sim 4.0 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA)}$

Maximum Ratings (Ta = 25°C)

Characteris	stics	Symbol	Rating	Unit
Drain-source voltage		V_{DSS}	500	V
Drain–gate voltage (R _{GS} = 20 kΩ)		V_{DGR}	500	V
Gate-source voltage		V_{GSS}	±30	V
Drain current	DC (Note 1)	I _D	14	Α
	Pulse (Note 1)	I _{DP}	56	Α
Drain power dissipation	n (Tc = 25°C)	P_{D}	80	W
Single pulse avalanche energy (Note 2)		E _{AS}	795	mJ
Avalanche current		I _{AR}	14	Α
Repetitive avalanche energy (Note 3)		E _{AR}	8	mJ
Channel temperature		T _{ch}	150	°C
Storage temperature ra	ange	T _{stg}	-55~150	°C

Weight: 5.8 g (typ.)

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	1.56	°C / W
Thermal resistance, channel to ambient	R _{th (ch-a)}	41.6	°C/W

Note 1: Please use devices on condition that the channel temperature is below 150°C.

Note 2: V_{DD} = 90 V, starting T_{ch} = 25°C, L = 6.9 mH, R_{G} = 25 Ω , I_{AR} = 14 A

Note 3: Repetitive rating: Pulse width limited by maximum channel temperature

This transistor is an electrostatic sensitive device.

Please handle with caution.

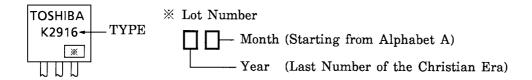
Electrical Characteristics (Ta = 25°C)

Charac	teristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	rrent	I _{GSS}	V _{GS} = ±25 V, V _{DS} = 0 V		_	±10	μΑ
Gate-source bre	eakdown voltage	V (BR) GSS	I _G = ±10 μA, V _{DS} = 0 V	±30	_	_	V
Drain cut-off cur	rent	I _{DSS}	V _{DS} = 500 V, V _{GS} = 0 V	_	_	100	μΑ
Drain-source br	eakdown voltage	V (BR) DSS	I _D = 10 mA, V _{GS} = 0 V	500	_	_	V
Gate threshold v	oltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	2.0	_	4.0	V
Drain-source Ol	N resistance	R _{DS (ON)}	V _{GS} = 10 V, I _D = 7.0 A	_	0.35	0.4	Ω
Forward transfer	admittance	Y _{fs}	V _{DS} = 10 V, I _D = 7.0 A	6	11	_	S
Input capacitanc	е	C _{iss}		_	2600	_	
Reverse transfer capacitance C _{rss}		V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	_	280	_	pF	
Output capacitance		Coss			880		_
Switching time	Rise time	t _r	$V_{GS} = 0V$ $I_{D} = 7.0A$ V_{OUT} $R_{L} = 30\Omega$	_	50	_	- ns
	Turn-on time	t _{on}		_	85	_	
	Fall time	t _f		_	65	_	
	Turn-off time	t _{off}	$V_{DD} = 210V$ Duty $\leq 1\%$, $t_{w} = 10 \mu s$	_	260	_	
Total gate charge (gate-source plus gate-drain)			_	58	_	nC	
Gate-source charge		Q _{gs}	$V_{DD} \approx 400 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 14 \text{ A}$		36		
Gate-drain ("miller") Charge		Q _{gd}			22		_

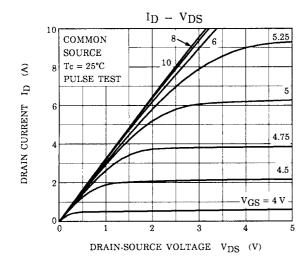
Source-Drain Ratings and Characteristics (Ta = 25°C)

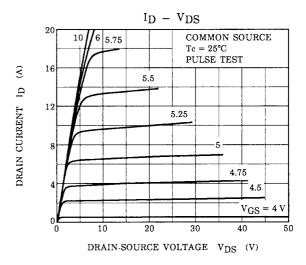
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	-	_	_	14	Α
Pulse drain reverse current (Note 1)	I _{DRP}	-	_	_	56	Α
Forward voltage (diode)	V _{DSF}	I _{DR} = 14 A, V _{GS} = 0 V	_	_	-1.7	V
Reverse recovery time	t _{rr}	I _{DR} = 14 A, V _{GS} = 0 V	1	400	_	ns
Reverse recovery charge	Q _{rr}	dl _{DR} / dt = 100 A / μs	_	4.3	_	μC

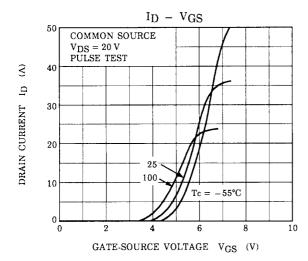
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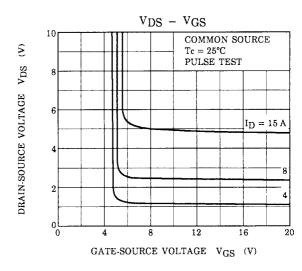


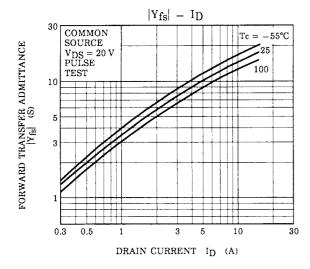
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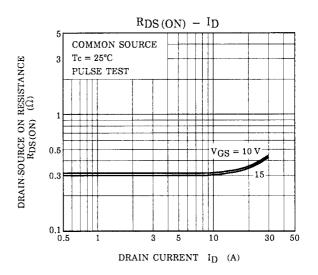




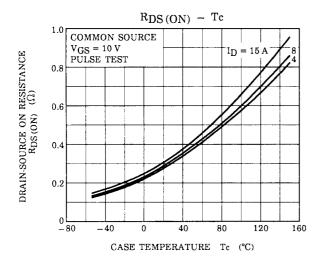


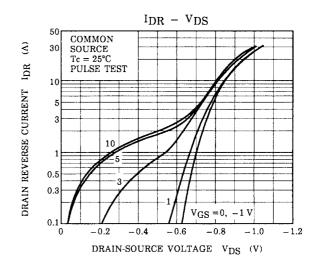


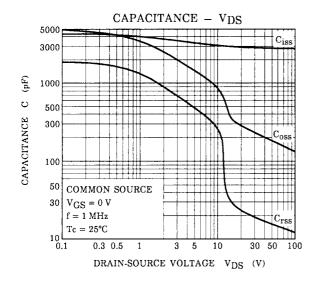


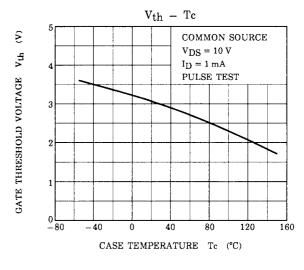


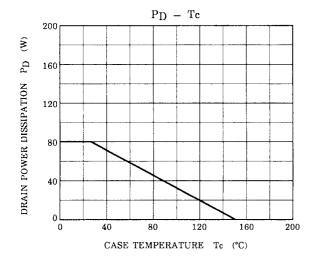
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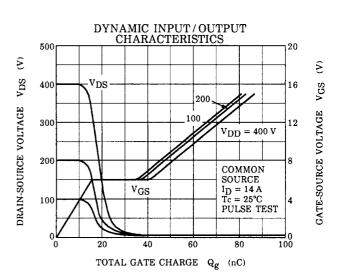




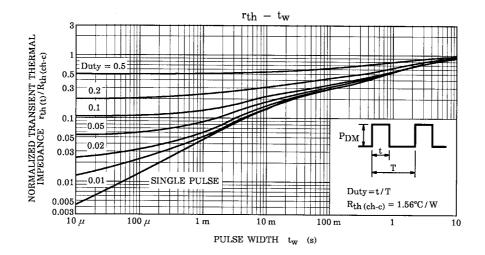


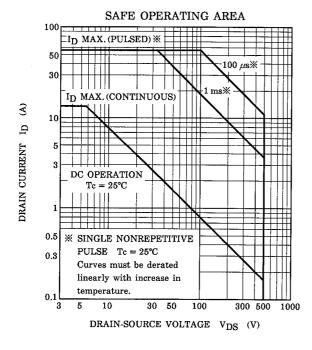


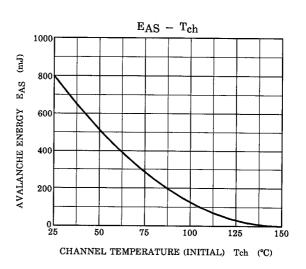


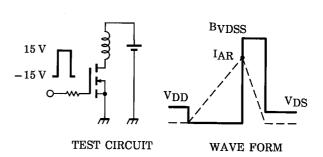


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$$R_G$$
 = 25 Ω
VDD = 90 V, L = 6.9 mH

$$E_{AS} = \frac{1}{2} \cdot L \cdot I^{2} \cdot \left(\frac{BVDSS}{BVDSS - VDD} \right)$$

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